

PORTAL
US Patent & Trademark Office

Subscribe (Full Service) Register (Limited Service, Free) Login

Search: The ACM Digital Library The Guide

+lotus +notes +"control document" +script +updating +struct

THE ACM DIGITAL LIBRARY

Feedback Report a problem Satisfaction survey

Terms used: **lotus notes control document script updating structure**

Found 1 of 132,857

Sort results by relevance Save results to a Binder
 Display results expanded form Search Tips Open results in a new window

Try an Advanced Search
 Try this search in [The ACM Guide](#)

Results 1 - 1 of 1

Relevance scale **1** [The Satchel system architecture: mobile access to documents and services](#) 

Mike Flynn, David Pendlebury, Chris Jones, Marge Eldridge, Mik Lamming

December 2000 **Mobile Networks and Applications**, Volume 5 Issue 4Full text available:  [pdf \(207.51 KB\)](#) Additional Information: [full citation](#), [abstract](#), [references](#), [citations](#), [index terms](#)

Mobile professionals require access to documents and document-related services, such as printing, wherever they may be. They may also wish to give documents to colleagues electronically, as easily as with paper, face-to-face, and with similar security characteristics. The Satchel system provides such capabilities in the form of a mobile browser, implemented on a device that professional people would be likely to carry anyway, such as a pager or mobile phone. Printing may be per ...

Results 1 - 1 of 1

The ACM Portal is published by the Association for Computing Machinery. Copyright © 2004 ACM, Inc.

[Terms of Usage](#) [Privacy Policy](#) [Code of Ethics](#) [Contact Us](#)Useful downloads:  [Adobe Acrobat](#)  [QuickTime](#)  [Windows Media Player](#)  [Real Player](#)

[IEEE HOME](#) | [SEARCH IEEE](#) | [SHOP](#) | [WEB ACCOUNT](#) | [CONTACT IEEE](#)[Membership](#) [Publications/Services](#) [Standards](#) [Conferences](#) [Careers/Jobs](#)**IEEE Xplore®**
RELEVANTWelcome
United States Patent and Trademark Office[Help](#) [FAQ](#) [Terms](#) [IEEE Peer Review](#)**Quick Links**

Log Out

Welcome to IEEE Xplore®

- Home
- What Can I Access?
- Log-out

CONTENT

- Journals & Magazines
- Conference Proceedings
- Standards

SEARCH

- By Author
- Basic
- Advanced

MEMBER SERVICES

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

 [Print Format](#)[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2004 IEEE — All rights reserved